



Material No.: 5374-03 Batch No.: 0000120306 Manufactured Date: 2015/08/24

Retest Date: 2020/08/22

## Certificate of Analysis

Test	Specification	Result
Assay (H <sub>2</sub> SO <sub>4</sub> )	95.0 - 97.0 %	96.2
Color (APHA)	<= 10	5
Chloride (CI)	<= 0.1 ppm	< 0.1
Nitrate (NO <sub>3</sub> )	<= 0.2 ppm	< 0.1
Phosphate (PO <sub>4</sub> )	<= 0.3 ppm	0.1
Trace Impurities - Aluminum (AI)	<= 50.0 ppb	< 5.0
Arsenic and Antimony (as As)	<= 5 ppb	< 2
Trace Impurities – Barium (Ba)	<= 50.0 ppb	< 1.0
Trace Impurities – Beryllium (Be)	<= 10.0 ppb	< 1.0
Trace Impurities - Bismuth (Bi)	<= 20.0 ppb	< 10.0
Trace Impurities - Boron (B)	<= 10.0 ppb	1.0
Trace Impurities - Cadmium (Cd)	<= 50.0 ppb	< 1.0
Trace Impurities - Calcium (Ca)	<= 100.0 ppb	16.0
Trace Impurities - Chromium (Cr)	<= 50.0 ppb	< 1.0
Trace Impurities - Cobalt (Co)	<= 50.0 ppb	< 1.0
Trace Impurities – Copper (Cu)	<= 10.0 ppb	< 1.0
Trace Impurities - Gallium (Ga)	<= 20.0 ppb	< 1.0
Trace Impurities - Germanium (Ge)	<= 100.0 ppb	< 10.0
Trace Impurities - Gold (Au)	<= 40.0 ppb	< 5.0
Trace Impurities - Iron (Fe)	<= 200.0 ppb	3.0
Trace Impurities - Lead (Pb)	<= 20.0 ppb	< 1.0
Trace Impurities - Lithium (Li)	<= 50.0 ppb	< 1.0
Trace Impurities - Magnesium (Mg)	<= 50.0 ppb	< 1.0
Trace Impurities - Manganese (Mn)	<= 10.0 ppb	< 1.0

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Trace Impurities - Molybdenum (Mo)	<= 10.0 ppb	< 5.0
Trace Impurities – Nickel (Ni)	<= 50.0 ppb	< 5.0
Trace Impurities – Niobium (Nb)	<= 10.0 ppb	< 1.0
Trace Impurities – Potassium (K)	<= 100.0 ppb	< 10.0
Trace Impurities – Silicon (Si)	<= 100.0 ppb	< 10.0
Trace Impurities – Silver (Ag)	<= 50.0 ppb	< 1.0
Trace Impurities – Sodium (Na)	<= 100.0 ppb	< 5.0
Trace Impurities – Strontium (Sr)	<= 10.0 ppb	< 1.0
Trace Impurities – Tantalum (Ta)	<= 10.0 ppb	< 0.9
Trace Impurities – Thallium (TI)	<= 20.0 ppb	< 5.0
Trace Impurities – Tin (Sn)	<= 50.0 ppb	< 10.0
Trace Impurities – Titanium (Ti)	<= 10.0 ppb	< 1.0
Trace Impurities – Vanadium (V)	<= 10.0 ppb	< 1.0
Trace Impurities – Zinc (Zn)	<= 50.0 ppb	< 1.0
Trace Impurities – Zirconium (Zr)	<= 10.0 ppb	< 0.1
Particle Count - 0.5 µm and greater	<= 80 par/ml	10
Particle Count - 1.0 µm and greater	<= 10 par/ml	2

For Microelectronic Use

Reported value is the average of all samples counted for this lot number, with no individual sample value exceeding the specification.

Storage Conditions: Recommended Storage Conditions: 15° – 100°F

Country of Origin: US

Packaging Site: Phillipsburg Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004, FSSC 22000
Paris, KY 9001:2008
Mexico City, Mexico 9001:2008
Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003
Gliwice, Poland 9001:2008
Selangor, Malaysia 9001:2008
Dehradun, India, 9001:2008, 14001:2004, 13485:2003
Mumbai, India, 9001:2008, 17025:2005

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